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Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/620,290	MEYER, HELMUT
Examiner	Art Unit
Maria Veronica D. Ewald	1722

SEARCHED			
Class	Subclass	Date	Examiner
425	326.1 Upd 24ed	4/15/2005 (11/21/05)	MVE (NVE)
425	66	4/15/2005	MVE
425	461	4/15/2005	MVE
264	209.5	4/15/2005	MVE
384	527	4/18/2005	MVE

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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TES STRATEGY))
DATE	EXMR
4/18/2005	MVE
4/15/2005	MVE
11/25/2005	MVE
	DATE 4/18/2005 4/15/2005